

Vishay Siliconix

P-Channel 8-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | |
|---------------------|--------------------------------------|--------------------|-----------------------|--|
| V _{DS} (V) | $R_{DS(on)}(\Omega)$ | I _D (A) | Q _g (Typ.) | |
| - 8 | 0.023 at $V_{GS} = -4.5 \text{ V}$ | - 12 ^a | | |
| | 0.031 at V _{GS} = - 2.5 V | - 12 ^a | | |
| | 0.040 at V _{GS} = - 1.8 V | - 12 ^a | 19 nC | |
| | 0.058 at V _{GS} = - 1.5 V | - 12 ^a | | |
| | 0.095 at V _{GS} = - 1.2 V | - 12 ^a | | |

FEATURES

- · Halogen-free
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] SC-70 Package

· Load Switch, PA Switch for Portable Devices

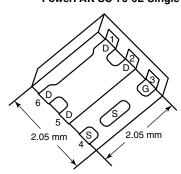
- Small Footprint Area
- Low On-Resistance

APPLICATIONS



RoHS

PowerPAK SC-70-6L-Single



Marking Code BHX Part # code





Ordering Information: SiA417DJ-T1-GE3 (Lead (Pb)-free and Halogen-free)

P-Channel MOSFET

| Parameter | | Symbol | Limit | Unit | |
|--|------------------------|-----------------------------------|-------------------------|----------|--|
| Drain-Source Voltage | | V _{DS} | - 8 | V | |
| Gate-Source Voltage | | V _{GS} | ± 5 | ¬ | |
| | T _C = 25 °C | | - 12 ^a | | |
| Continuous Drain Current (T _{.1} = 150 °C) | T _C = 70 °C | I _D | - 12 ^a | | |
| Continuous Brain Current (1) = 130 C) | T _A = 25 °C | 'b | - 12 ^{a, b, c} | | |
| | T _A = 70 °C | | - 8.3 ^{b, c} | A | |
| Pulsed Drain Current | | I _{DM} | - 30 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | l _a | - 12 ^a | | |
| | T _A = 25 °C | I _S | - 2.9 ^{b, c} | | |
| Maximum Power Dissipation | T _C = 25 °C | | 19 | | |
| | T _C = 70 °C | P _D | 12 | \Box w | |
| | T _A = 25 °C | ' D | 3.5 ^{b, c} | VV | |
| | T _A = 70 °C | | 2.2 ^{b, c} | | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to 150 | °C | |
| Soldering Recommendations (Peak Temperature) ^{d, e} | | Ĭ | 260 | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{b, f} | t ≤ 5 s | R _{thJA} | 28 | 36 | °C/W | |
| Maximum Junction-to-Case (Drain) | Steady State | R_{thJC} | 5.3 | 6.5 | 0/11 | |

Notes:

- a. Package limited
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SC-70 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 80 °C/W.

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| SPECIFICATIONS $T_J = 25 ^{\circ}\text{C}$ Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
|--|----------------------------------|---|--------|--------|-------|-------------|--|
| Static | | 1001 001101110 | | .,,,,, | | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | - 8 | | | V | |
| V _{DS} Temperature Coefficient | ΔV _{DS} /T _J | | | - 7.3 | | mV/°C | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = - 250 μA | | 2.5 | | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | - 0.35 | | - 1 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$ | | | ± 100 | nA | |
| | | V _{DS} = -8 V, V _{GS} = 0 V | | | - 1 | μΑ | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = -8 V, V _{GS} = 0 V, T _J = 55 °C | | | - 10 | | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$ | - 10 | | | Α | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = - 4.5 V, I _D = - 7 A | | 0.019 | 0.023 | | |
| | | V _{GS} = - 2.5 V, I _D = - 6 A | | 0.026 | 0.031 | | |
| | | V _{GS} = - 1.8 V, I _D = - 5.3 A | | 0.033 | 0.040 | Ω | |
| Diam coulde on clate Hesistance | 23(011) | $V_{GS} = -1.5 \text{ V}, I_D = -1.7 \text{ A}$ | | 0.043 | 0.058 | | |
| | | V _{GS} = - 1.2 V, I _D = - 1.1 A | | 0.063 | 0.095 | 1 | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = - 4 V, I _D = - 7 A | | 23 | 0.000 | S | |
| Dynamic ^b | 013 | D3 , D | | | | | |
| Input Capacitance | C _{iss} | | | 1600 | | | |
| Output Capacitance | C _{oss} | V _{DS} = - 4 V, V _{GS} = 0 V, f = 1 MHz | | 500 | | pF | |
| Reverse Transfer Capacitance | C _{rss} | VDS - 4 V, VGS - 0 V, I - I WII 12 | | 320 | | | |
| neverse transier Capacitance | orss | V _{DS} = - 4 V, V _{GS} = - 5 V, I _D = - 10 A | | 21 | 20 | 32 | |
| Total Gate Charge | Q_g | V _{DS} = -4 V, V _{GS} = -5 V, I _D = -10 A | | 19 | 29 | nC | |
| Gate-Source Charge | Q _{gs} | $V_{DS} = -4 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$ | | 2.2 | 20 | | |
| Gate-Drain Charge | Q _{gd} | -DS, -GS, -D | | 5 | | | |
| Gate Resistance | R _g | f = 1 MHz | | 8 | | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 15 | 25 | | |
| Rise Time | t _r | $V_{DD} = -4 \text{ V}, R_1 = 0.5 \Omega$ | | 25 | 38 | - - - | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong -8.3 \text{ A, V}_{GEN} = -4.5 \text{ V, R}_g = 1 \Omega$ | | 80 | 120 | | |
| Fall Time | t _f | | | 45 | 70 | | |
| Turn-On Delay Time | t _{d(on)} | | | 10 | 15 | ns | |
| Rise Time | t _r | $V_{DD} = -4 \text{ V}, R_1 = 0.5 \Omega$ | | 12 | 20 | - - - | |
| Turn-Off Delay Time | t _{d(off)} | | | 80 | 120 | | |
| Fall Time | t _f | g | | 45 | 70 | | |
| Drain-Source Body Diode Characterist | | | | | | | |
| Continuous Source-Drain Diode Current I _S | | T _C = 25 °C | | | - 12 | | |
| Pulse Diode Forward Current | I _{SM} | - | | | - 30 | _ A | |
| Body Diode Voltage | V _{SD} | I _S = - 8.3 A, V _{GS} = 0 V | | - 0.8 | - 1.2 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | - 35 | | 60 | 90 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | 1 | | 33 | 50 | nC | |
| Reverse Recovery Fall Time | t _a | - I _F = - 8.3 A, di/dt = 100 A/μs, T _J = 25 °C | | 15 | | ns | |
| Reverse Recovery Rise Time | t _b | | | 45 | | | |

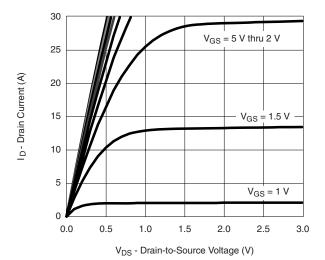
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

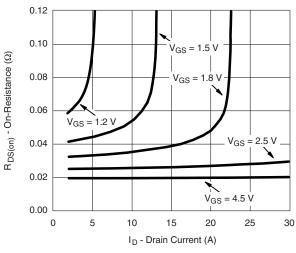


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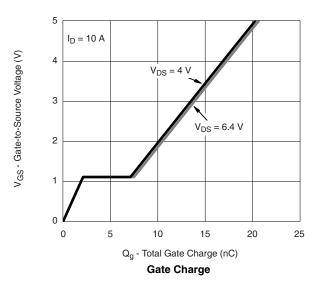
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

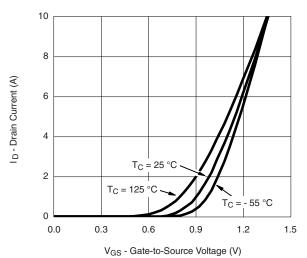


Output Characteristics

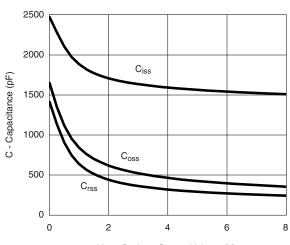


On-Resistance vs. Drain Current and Gate Voltage

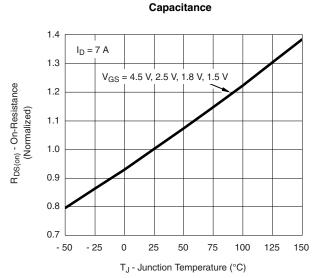




Transfer Characteristics



 V_{DS} - Drain-to-Source Voltage (V)



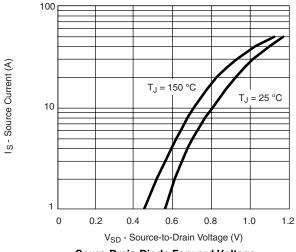
On-Resistance vs. Junction Temperature

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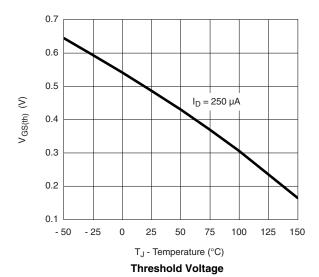
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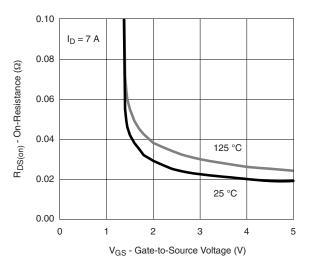
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

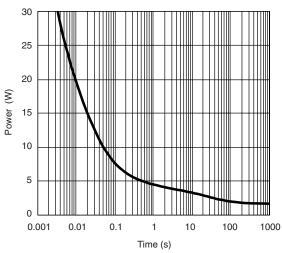


Soure-Drain Diode Forward Voltage

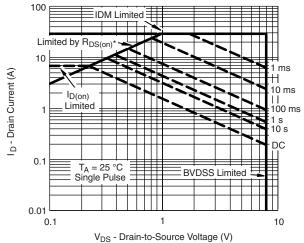




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

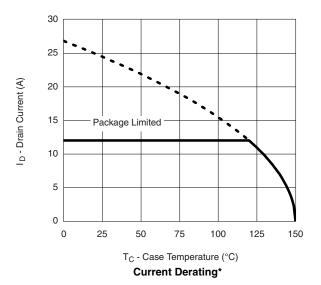
Safe Operating Area, Junction-to-Ambient

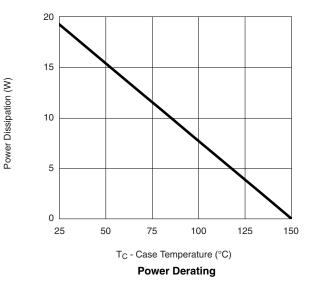




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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





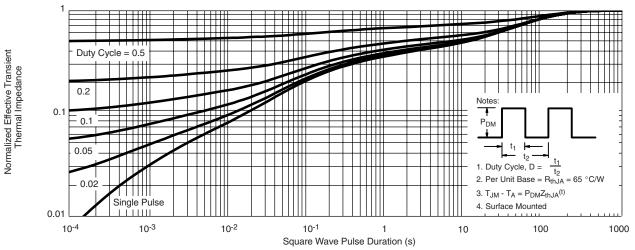
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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